

NOTE:

1. NO DISLODMENT OF THE CELL OR DAMAGE TO RETAINER WITH THE FOLLOWING TESTS:

- INTEGRITY VIBRATION TEST PER MIL-STD-810G METHOD 516.6
- SHOCK TEST PER MIL-STD-810G METHOD 516.6
- BENCH HANDLING SHOCK TEST PER MIL-STD 810G METHOD 516.6
- TRANSIT DROP TEST PER MIL-STD 810G METHOD 516.6

2. TAPE AND REEL SPECIFICATIONS:

a) TAPE:

MAT'L - ALL CONDUCTIVE POLYSTYRENE CARRIER
ANSI/EIA-481 STANDARD

b) REEL:

13.0 [330.2] DIA. 500 PIECES OF
PART NO. 2898 PER REEL.

KEYSTONE ELECTRONICS CORP.

www.keyelco.com • NEW HYDE PARK, NY 11040 • Tel (516) 328-7500

PART NAME

CR2032 COIN CELL CLIP ON TAPE

MATERIAL

AS NOTED

FINISH

AS NOTED

DRN BY

NT

DATE

9.19.18

APP'D

RH

SCALE

X

TOLERANCES

INCH [MM]

DECIMAL

± .015 [± 0.38]

ANGULAR

± 1°

UNLESS OTHERWISE SPECIFIED

CODE

C

DWG NO.

2898TR

3.30.20

ECN 20-032 ADD NOTE 1.

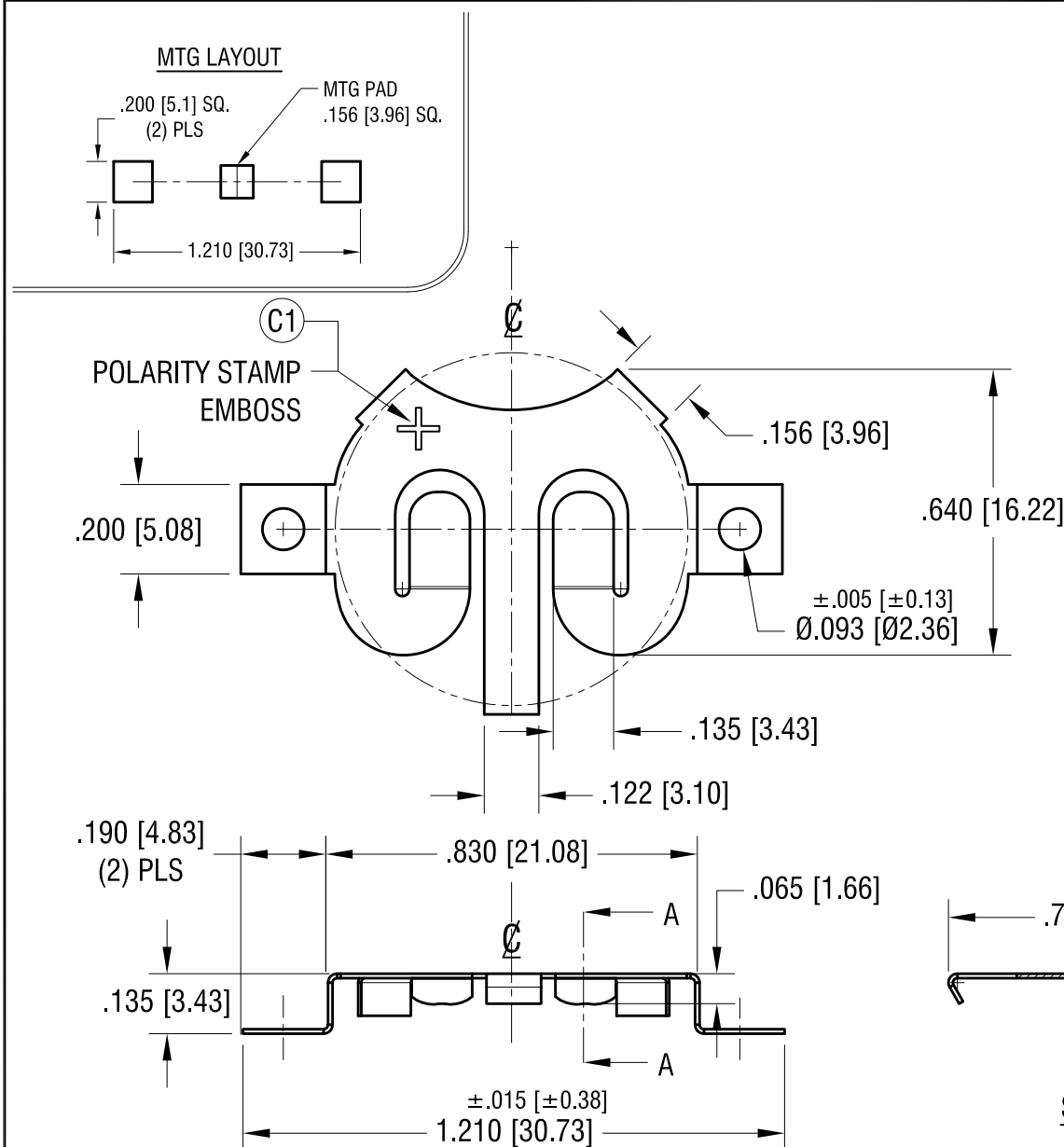
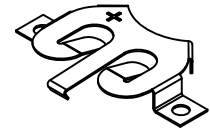
A

DATE

DESCRIPTION

REV.

ACTUAL SIZE



NOTE:

1. NO DISLODGMET OF THE CELL OR DAMAGE TO RETAINER WITH THE FOLLOWING TESTS:

- INTEGRITY VIBRATION TEST PER MIL-STD-810G METHOD 516.6
- SHOCK TEST PET MIL-STD-810G METHOD 516.6
- BENCH HANDLING SHOCK TEST PER MIL-STD 810G METHOD 516.6
- TRANSIT DROP TEST PER MIL-STD 810G METHOD 516.6

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1.11.23	STAMP (C1) WAS CUT THRU CHANGE AS PER ECN 23-026	C	PART NAME 2032 COIN CELL SM RETAINER
3.30.20	ADDED NOTE 1. CHANGE AS PER ECN 20-031	B	MATERIAL .010 [0.25] TH'K PHOSPHOR BRONZE
5.13.19	REMOVE DIMPLES CHANGE AS PER ECN 19-053	A	FINISH TIN NICKEL PLATE
DATE	DESCRIPTION	REV.	DRN BY NT APP'D RH SCALE 2.5X TOLERANCES INCH [MM] DECIMAL $\pm .010 [\pm 0.25]$ ANGULAR $\pm 1^\circ$ UNLESS OTHERWISE SPECIFIED
			CODE C
			DWG NO. 2898